Special Issue

Image-Based Object Detection

Message from the Guest Editor

Image-based object detection, a cornerstone of computer vision, enables machines to identify and localize objects in visual data, underpinning advancements in autonomous driving, surveillance, medical imaging, and robotics. In recent years, transformative progress, driven by deep learning, has been made, from convolutional neural networks (CNNs) to transformer-based architectures, yet critical challenges persist, such as handling occlusions, small/low-light objects, domain shifts, and real-time efficiency in dynamic environments. This Special Issue aims to showcase cutting-edge research addressing these hurdles. We welcome the submission of original contributions focused on novel algorithms, benchmark datasets, robustness enhancements (e.g., against adversarial attacks), and cross-domain applications. By integrating theoretical innovations with practical solutions, this Special Issue seeks to accelerate the translation of image-based detection technologies to real-world impacts.

Guest Editor

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Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal *Applied Sciences* has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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